

OPA727, OPA2727 OPA4727, OPA728

SBOS314F - SEPTEMBER 2004 - REVISED OCTOBER 2006

e-trim[™] 20MHz, High Precision CMOS Operational Amplifier

FEATURES

OFFSET: 15μV (typ), 150μV (max)
 DRIFT: 0.3μV/°C (typ), 1.5μV/°C (max)

BANDWIDTH: 20MHzSLEW RATE: 30V/μs

BIAS CURRENT: 500pA (max)
 LOW NOISE: 6nV/√Hz at 100kHz

• THD+N: 0.0003% at 1kHz

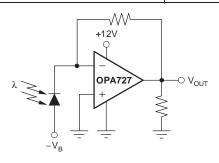
QUIESCENT CURRENT: 4.3mA/ch
 SUPPLY VOLTAGE: 4V to 12V
 SHUTDOWN MODE (OPA728): 6μA

APPLICATIONS

- OPTICAL NETWORKING
- TRANSIMPEDANCE AMPLIFIERS
- INTEGRATORS
- ACTIVE FILTERS
- A/D CONVERTER DRIVERS
- I/V CONVERTER FOR DACs
- HIGH PERFORMANCE AUDIO
- PROCESS CONTROL
- TEST EQUIPMENT

OPAX727 AND OPAX728 RELATED PRODUCTS

FEATURES	PRODUCT
20MHz, 3mV, 4μV/°C (non-e-trim version of OPA727)	OPA725
20MHz, 3mV, 4μV/°C, Shutdown (non-e-trim version of OPA728)	OPA726



DESCRIPTION

The OPA727 and OPA728 series op amps use a state-of-the-art 12V analog CMOS process and *e-trim*, a package-level trim, offering outstanding dc precision and ac performance. The extremely low offset (150 μ V max) and drift (1.5 μ V/°C) are achieved by trimming the IC digitally after packaging to avoid the shift in parameters as a result of stresses during package assembly. To correct for offset drift, the OPA727 and OPA728 family is trimmed over temperature. The devices feature very high CMRR and open-loop gain to minimize errors.

Excellent ac characteristics, such as 20MHz GBW, $30V/\mu s$ slew rate and 0.0003% THD+N make the OPA727 and OPA728 well-suited for communication, high-end audio, and active filter applications. With a bias current of less than 500pA, they are well suited for use as transimpedance (I/V-conversion) amplifiers for monitoring optical power in ONET applications.

Optimized for single-supply operation up to 12V, the input common-mode range extends to GND for true single-supply functionality. The output swings to within 150mV of the rails, maximizing dynamic range. The low quiescent current of 4.3mA makes it well-suited for use in battery-operated equipment. The OPA728 shutdown version reduces the quiescent current to typically $6\mu A$ and features a reference pin for easy shutdown operation with standard CMOS logic in dual-supply applications.

For ease of use, the OPA727 and OPA728 op amp families are fully specified and tested over the supply range of 4V to 12V. The OPA727 (single) and OPA728 (single with shutdown) are available in MSOP-8 and DFN-8; the OPA2727 (dual) is available in DFN-8 and SO-8 available Q4'06; and the quad version OPA4727 in TSSOP-14. All versions are specified for operation from -40°C to $+125^{\circ}\text{C}$.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

e-trim™ is a trademark of Texas Instruments, Incorporated. All other trademarks are the property of their respective owners





PACKAGE/ORDERING INFORMATION(1)

PRODUCT	PACKAGE-LEAD	PACKAGE DESIGNATOR	PACKAGE MARKING
Non-Shutdown			
OD4 707	MSOP-8	DGK	AUE
OPA727	DFN-8	DRB	NSF
004.0707	DFN-8	DRB	NSD
OPA2727	SO-8 ⁽²⁾	D	OPA2727A
OPA4727	TSSOP-14	PW	OPA4727
Shutdown			
OPA728	MSOP-8	DGK	AUF
UPA728	DFN-8	DRB	NSG

⁽¹⁾ For the most current package and ordering information see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

ABSOLUTE MAXIMUM RATINGS(1)

Supply Voltage
Signal Input Terminals, Voltage ⁽²⁾ 0.5V to (V+) + 0.5V
Current(2) ±10mA
Output Short-Circuit ⁽³⁾ Continuous
Operating Temperature–55°C to +125°C
Storage Temperature
Junction Temperature
ESD Rating (Human Body Model)
(Charged Device Model) 1000V

- (1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not supported.
- (2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5V beyond the supply rails should be current limited to 10mA or less.
- (3) Short-circuit to ground, one amplifier per package.



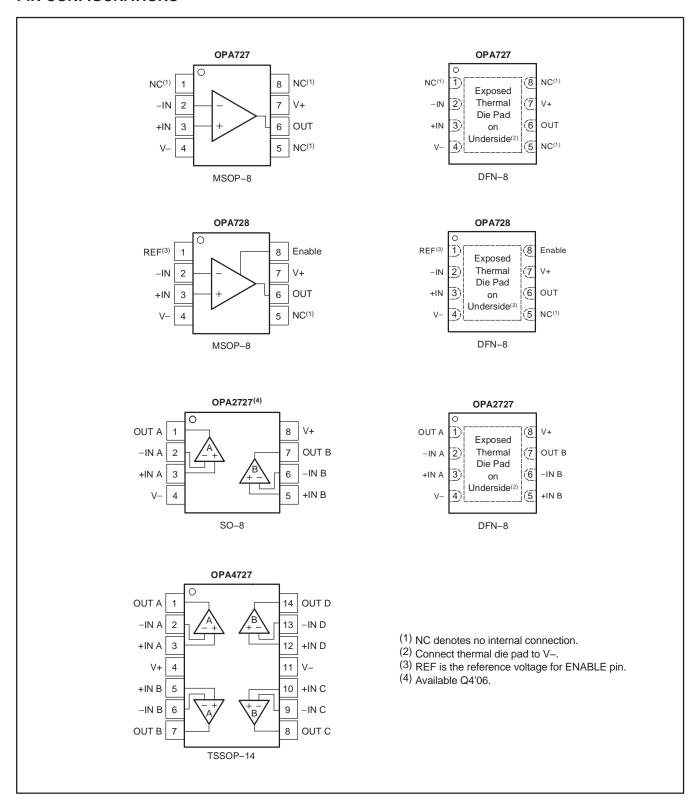
This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

⁽²⁾ Available Q4'06.



PIN CONFIGURATIONS





ELECTRICAL CHARACTERISTICS: $V_S = +4V$ to +12V or $V_S = \pm 2V$ to $\pm 6V$ Boldface limits apply over the specified temperature range, $T_A = -40^{\circ}C$ to +125°C.

		OPA727, OPA728, OPA2727, OPA4727			
PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET VOLTAGE					
Input Offset Voltage V _{OS}	$V_S = \pm 5V$, $V_{CM} = 0V$				
OPA727 DFN, OPA728 DFN Packages			15	150	μV
OPA727 MSOP, OPA728 MSOP Packages			15	300	μV
OPA2727			15	150	μV
OPA4727			15	175	μV
Drift dV _{OS} /dT	0°C to +85°C		0.3	1.5	μV/°C
	-40°C to +125°C		0.6	3	μ ۷/ ° C
vs Power Supply PSRR	$V_S = \pm 2V$ to $\pm 6V$, $V_{CM} = V$		30	150	μV/V
Over Temperature	$V_S = \pm 2V$ to $\pm 6V$, $V_{CM} = V$			150	μ V/V
Channel Separation, dc			1		μV/V
INPUT BIAS CURRENT					
Input Bias Current			±85	±500	pА
Over Temperature		See Ty	pical Charac	teristics	
Input Offset Current I _{OS}			±10	±100	рА
NOISE					
Input Voltage Noise, f = 0.1Hz to 10Hz e _n	$V_{S} = \pm 6V, V_{CM} = 0V$		10		μV _{PP}
Input Voltage Noise Density, f = 10kHz e _n	$V_{S} = \pm 6V, V_{CM} = 0V$		10		nV/√ Hz
Input Voltage Noise Density, f = 100kHz e _n	$V_{S} = \pm 6V, V_{CM} = 0V$		6		nV/√ Hz
Input Current Noise Density, f = 1kHz i _n	$V_S = \pm 6V$, $V_{CM} = 0V$		2.5		fA/√ Hz
INPUT VOLTAGE RANGE					
Common-Mode Voltage Range V _{CM}		(V-)		(V+) - 2.5	V
Common-Mode Rejection Ratio CMRR	$(V-) \le V_{CM} \le (V+) - 2.5V$	86	94		dB
Over Temperature	$(V-) \le V_{CM} \le (V+) - 2.5V$	84			dB
•	$(V-) \le V_{CM} \le (V+) - 3V$	94	100		dB
Over Temperature	$(V-) \le V_{CM} \le (V+) - 3V$	84			dB
INPUT IMPEDANCE					
Differential			1011 5		Ω pF
Common-Mode			1011 4		Ω pF
OPEN-LOOP GAIN					
Open-Loop Voltage Gain A _{OL}					
	$R_{\perp} = 100 k\Omega$, $0.15 V < V_{O} < (V+) - 0.15 V$	110	120		dB
Over Temperature	$R_1 = 100k\Omega$, $0.15V < V_0 < (V+) - 0.15V$	100			dB
, , , , , , , , , , , , , , , , , , ,	$R_L = 1k\Omega$, $0.25V < V_O < (V+) - 0.25V$	106	116		dB
Over Temperature, OPA727, OPA728	$R_1 = 1k\Omega$, 0.25V < V_0 < (V+) - 0.25V	96			dB
Over Temperature, OPA2727, OPA4727	$R_L = 1k\Omega$, 0.35V < V_O < (V+) - 0.35V	96			dB
FREQUENCY RESPONSE	C _L = 20pF				
Gain-Bandwidth Product GBW			20		MHz
Slew Rate SR	G = +1		30		V/µs
Settling Time, 0.1% t _S	$V_S = \pm 6V, 5V \text{ Step}, G = +1$		350		ns
0.01%	$V_S = \pm 6V$, 5V Step, G = +1		450		ns
Overload Recovery Time	$V_{IN} \times Gain > V_{S}$		50		ns
Total Harmonic Distortion + Noise THD+N	$V_S = \pm 6V$, $V_{OUT} = 2V_{RMS}$, $R_L = 600\Omega$,		0.0003		%
	G = +1, f = 1kHz				

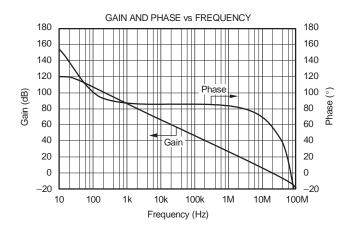


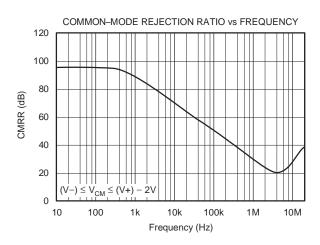
ELECTRICAL CHARACTERISTICS: $V_S = +4V$ to +12V or $V_S = \pm 2V$ to $\pm 6V$ (continued) Boldface limits apply over the specified temperature range, $T_A = -40^{\circ}C$ to $+125^{\circ}C$.

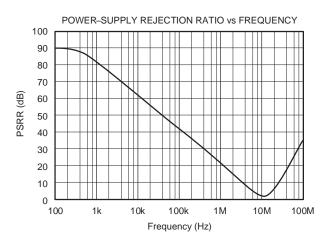
		OPA727, OP			
PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT					
Voltage Output Swing from Rail					
	$R_L = 100k\Omega, A_{OL} > 110dB$		100	150	mV
Over Temperature	$R_L = 100k\Omega, A_{OL} > 100dB$			150	mV
	$R_L = 1k\Omega$, $A_{OL} > 106dB$		200	250	mV
Over Temperature, OPA727, OPA728	$R_L = 1k\Omega$, $A_{OL} > 96dB$			250	mV
Over Temperature, OPA2727, OPA4727	$R_L = 1k\Omega$, $A_{OL} > 96dB$			350	mV
Output Current I _{OUT}	V _S – V _{OUT} < 1V		40		mA
Short-Circuit Current I _{SC}			±55		mA
Capacitive Load Drive C _{LOAD}		See Ty	pical Charac	teristics	
Open-Loop Output Impedance	$f = 1MHz, I_O = 0$		40		Ω
ENABLE/SHUTDOWN (OPA728)					
t _{OFF}		j	5		μs
t _{ON}			80		μs
Enable Reference (Ref Pin) Voltage Range		V-		(V+) – 2	V
V _L (amplifier is disabled)				$< V_{DGND} + 0.8V$	V
V _H (amplifier is enabled)		> V _{DGND} + 2V			V
Input Bias Current of Enable Pin			5		pА
I _{QSD}	Amplifier Disabled		6	15	μΑ
POWER SUPPLY					
Specified Voltage Range V _S		4		12	V
Operating Voltage Range V _S			3.5 to 13.2		V
Quiescent Current (per amplifier) I _Q	I _O = 0		4.3	6.5	mA
Over Temperature				6.5	mA
TEMPERATURE RANGE					
Specified Range		-40		+125	°C
Operating Range		-55		+125	°C
Storage Range		-55		+150	°C
Thermal Resistance $ heta_{ m JA}$					
MSOP-8, SO-8			150		°C/W
TSSOP-14			100		°C/W
DFN-8			46		°C/W

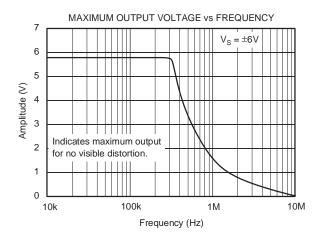


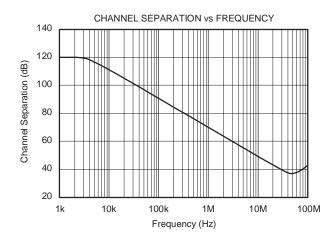
TYPICAL CHARACTERISTICS

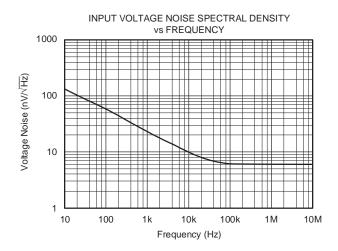




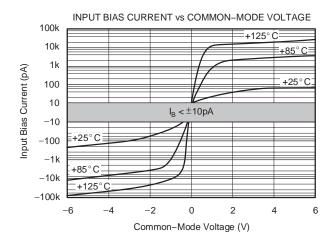


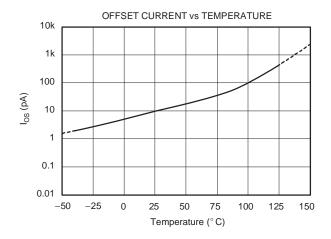


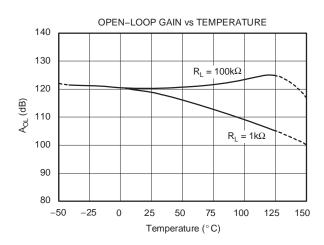


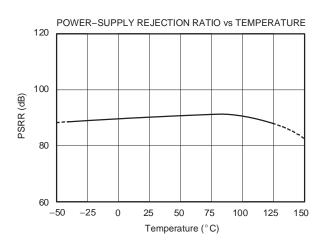


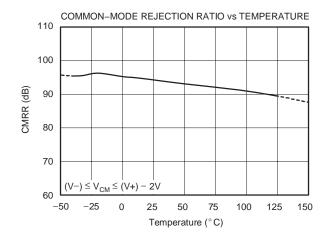


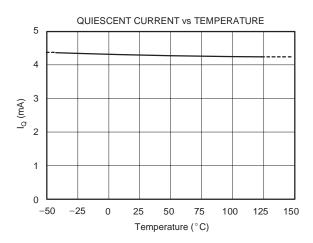




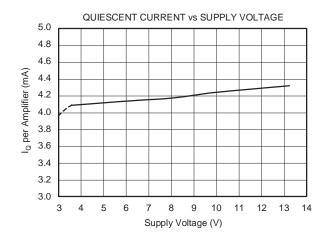


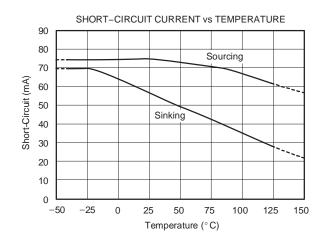


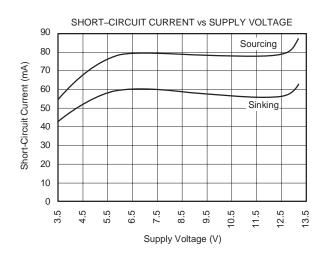


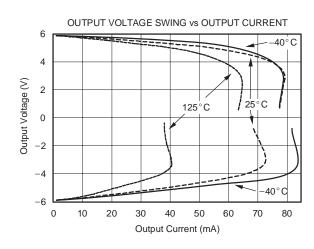


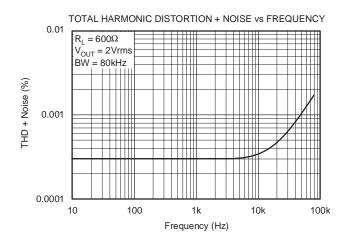


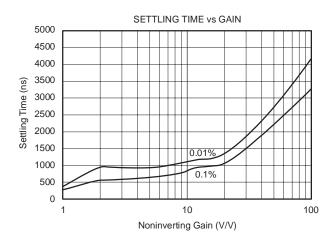




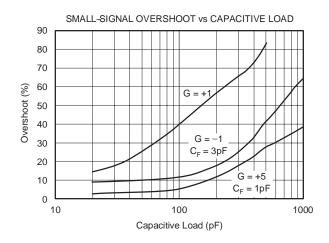


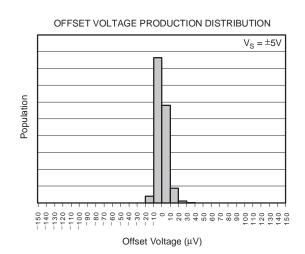


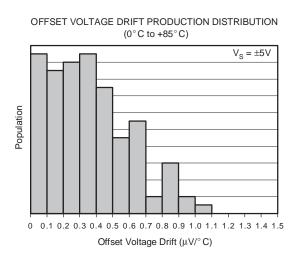


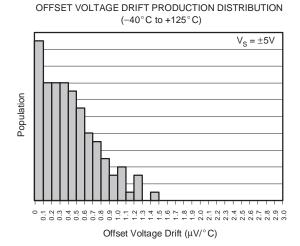


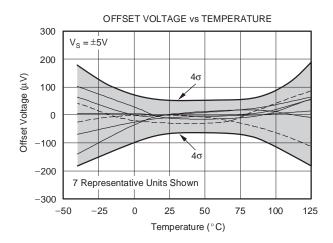


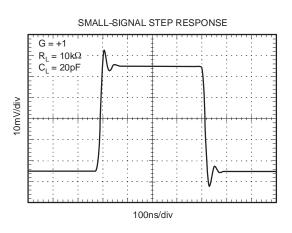




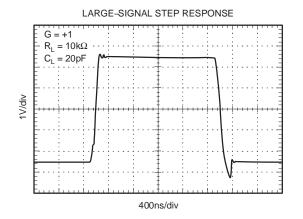


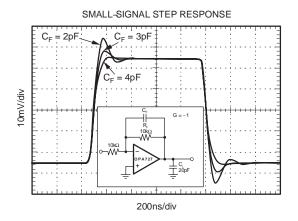


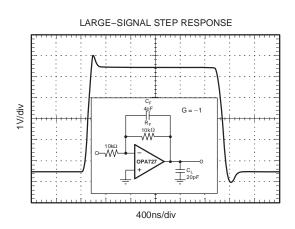














APPLICATIONS INFORMATION

The OPA727 and OPA728 family of op amps use *e-trim*, an adjustment to offset voltage and temperature drift made during the final steps of manufacturing after the plastic molding is completed. This compensates for performance shifts that can occur during the molding process. Through *e-trim*, the OPA727 and OPA728 deliver excellent offset voltage (150 μ V max) and extremely low offset voltage drift (1.5 μ V/°C). Additionally, these 20MHz CMOS op amps have a fast slew rate, low noise, and excellent PSRR, CMRR, and A_{OL}. They can operate on typically 4.3mA quiescent current from a single (or split) supply in the range of 4V to 12V (\pm 2V to \pm 6V), making them highly versatile and easy to use. They are stable in a unity-gain configuration.

Power-supply pins should be bypassed with 1nF ceramic capacitors in parallel with 1μ F tantalum capacitors.

OPERATING VOLTAGE

OPA727 series op amps are specified from 4V to 12V supplies over a temperature range of -40° C to $+125^{\circ}$ C. They will operate well in ± 5 V or +5V to +12V power-supply systems. Parameters that vary significantly with operating voltage or temperature are shown in the Typical Characteristics.

ENABLE/SHUTDOWN

OPA727 series op amps require approximately 4.3mA quiescent current. The enable/shutdown feature of the OPA728 allows the op amp to be shut off to reduce this current to approximately 6μ A.

The enable/shutdown input is referenced to the Enable Reference Pin, DGND (see *Pin Configurations*). This pin can be connected to logic ground in dual-supply op amp configurations to avoid level-shifting the enable logic signal, as shown in Figure 1.

The Enable Reference Pin voltage, V_{DGND} , must not exceed (V+) – 2V. It may be set as low as V–. The amplifier is enabled when the Enable Pin voltage is greater than V_{DGND} + 2V. The amplifier is disabled (shutdown) if the Enable Pin voltage is less than V_{DGND} + 0.8V. The Enable Pin is connected to internal pull-up circuitry and will enable the device if left unconnected.

COMMON-MODE VOLTAGE RANGE

The input common-mode voltage range of the OPA727 and OPA728 series extends from V- to (V+)-2.5V.

Common-mode rejection is excellent throughout the input voltage range from V- to (V+) – 3V. CMRR decreases somewhat as the common-mode voltage extends to (V+) – 2.5V, but remains very good and is tested throughout this range. See the *Electrical Characteristics* table for details.

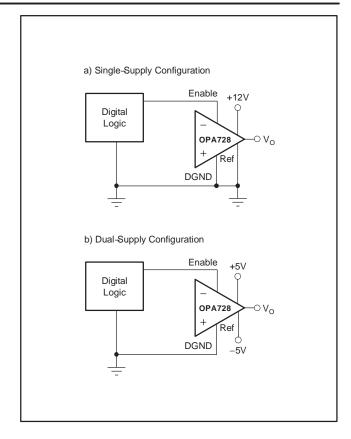


Figure 1. Enable Reference Pin Connection for Single- and Dual-Supply Configurations

INPUT OVER-VOLTAGE PROTECTION

Device inputs are protected by ESD diodes that will conduct if the input voltages exceed the power supplies by more than approximately 300mV. Momentary voltages greater than 300mV beyond the power supply can be tolerated if the current is limited to 10mA. This is easily accomplished with an input resistor in series with the op amp, as shown in Figure 2. The OPA727 series features no phase inversion when the inputs extend beyond supplies, if the input is current limited.

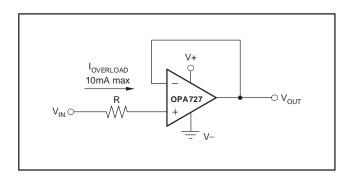


Figure 2. Input Current Protection for Voltages
Exceeding the Supply Voltage



RAIL-TO-RAIL OUTPUT

A class AB output stage with common-source transistors is used to achieve rail-to-rail output. This output stage is capable of driving heavy loads connected to any point between V+ and V–. For light resistive loads (> $100k\Omega$), the output voltage can swing to 150mV from the supply rail, while still maintaining excellent linearity (A $_{OL}$ > 110dB). With $1k\Omega$ resistive loads, the output is specified to swing to within 250mV from the supply rails with excellent linearity (see the Typical Characteristics curve, $Output\ Voltage\ Swing\ vs\ Output\ Current$).

CAPACITIVE LOAD AND STABILITY

Capacitive load drive is dependent upon gain and the overshoot requirements of the application. Increasing the gain enhances the ability of the amplifier to drive greater capacitive loads (see the Typical Characteristics curve, Small-Signal Overshoot vs Capacitive Load).

One method of improving capacitive load drive in the unity-gain configuration is to insert a 10Ω to 20Ω resistor inside the feedback loop, as shown in Figure 3. This reduces ringing with large capacitive loads while maintaining DC accuracy.

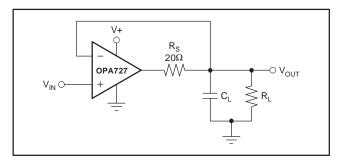


Figure 3. Series Resistor in Unity-Gain Buffer Configuration Improves Capacitive Load Drive

DRIVING FAST 16-BIT ADCs

The OPA727 series is optimized for driving fast 16-bit ADCs such as the ADS8342. The OPA727 op amps buffer the converter input capacitance and resulting charge injection, while providing signal gain. Figure 4 shows the OPA727 in a single-ended method of interfacing to the ADS8342 16-bit, 250kSPS, 4-channel ADC with an input range of ±2.5V. The OPA727 has demonstrated excellent settling time to the 16-bit level within the 600ns acquisition time of the ADS8342. The RC filter, shown in Figure 4, has been carefully tuned for best noise and settling performance. It may need to be adjusted for different op amp configurations. Please refer to the ADS8342 data sheet (available for download at www.ti.com) for additional information on this product.

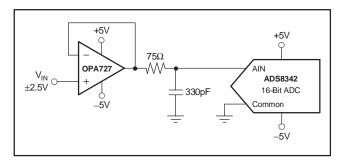


Figure 4. OPA727 Driving an ADC

TRANSIMPEDANCE AMPLIFIER

Wide bandwidth, low input bias current, and low input voltage and current noise make the OPA727 an ideal wideband photodiode transimpedance amplifier. Low-voltage noise is important because photodiode capacitance causes the effective noise gain of the circuit to increase at high frequency.

The key elements to a transimpedance design, as shown in Figure 5, are the expected diode capacitance (C_D), which should include the parasitic input common-mode and differential-mode input capacitance (4pF + 5pF for the OPA727); the desired transimpedance gain (R_F); and the GBW for the OPA727 (20MHz). With these three variables set, the feedback capacitor value (C_F) can be set to control the frequency response. C_F includes the stray capacitance of R_F , which is 0.2pF for a typical surface-mount resistor.

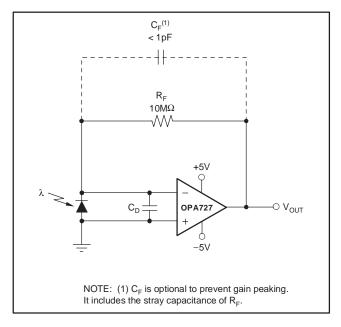


Figure 5. Dual-Supply Transimpedance Amplifier



To achieve a maximally-flat, 2nd-order Butterworth frequency response, the feedback pole should be set to:

$$\frac{1}{2\pi R_F C_F} = \sqrt{\frac{GBW}{4\pi R_F C_D}}$$
 (1)

Bandwidth is calculated by:

$$f_{-3dB} = \sqrt{\frac{GBW}{2\pi R_F C_D}} Hz$$
 (2)

For even higher transimpedance bandwidth, the high-speed CMOS OPA380 (90MHz GBW), OPA354 (100MHz GBW), OPA300 (180 MHz GBW), OPA355 (200MHz GBW), or OPA656, OPA657 (400MHz GBW) may be used.

For single-supply applications, the +IN input can be biased with a positive dc voltage to allow the output to reach true zero when the photodiode is not exposed to any light, and respond without the added delay that results from coming out of the negative rail; this is shown in Figure 6. This bias voltage also appears across the photodiode, providing a reverse bias for faster operation.

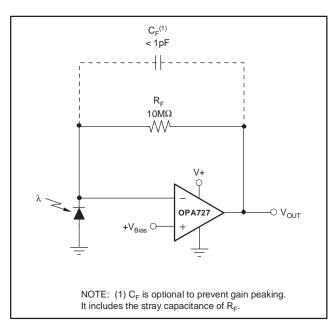


Figure 6. Single-Supply Transimpedance Amplifier

For additional information, refer to Application Bulletin SBOA055, Compensate Transimpedance Amplifiers Intuitively, available for download at www.ti.com.

OPTIMIZING THE TRANSIMPEDANCE CIRCUIT

To achieve the best performance, components should be selected according to the following guidelines:

- 1. For lowest noise, select R_F to create the total required gain. Using a lower value for R_F and adding gain after the transimpedance amplifier generally produces poorer noise performance. The noise produced by R_F increases with the square-root of R_F, whereas the signal increases linearly. Therefore, signal-to-noise ratio is improved when all the required gain is placed in the transimpedance stage.
- 2. Minimize photodiode capacitance and stray capacitance at the summing junction (inverting input). This capacitance causes the voltage noise of the op amp to be amplified (increasing amplification at high frequency). Using a low-noise voltage source to reverse-bias a photodiode can significantly reduce its capacitance. Smaller photodiodes have lower capacitance. Use optics to concentrate light on a small photodiode.
- Noise increases with increased bandwidth. Limit the circuit bandwidth to only that required. Use a capacitor across the R_F to limit bandwidth, even if not required for stability.
- 4. Circuit board leakage can degrade the performance of an otherwise well-designed amplifier. Clean the circuit board carefully. A circuit board guard trace that encircles the summing junction and is driven at the same voltage can help control leakage.

For additional information, refer to the Application Bulletins *Noise Analysis of FET Transimpedance Amplifiers* (SBOA060), and *Noise Analysis for High-Speed Op Amps* (SBOA066), available for download at the TI web site.



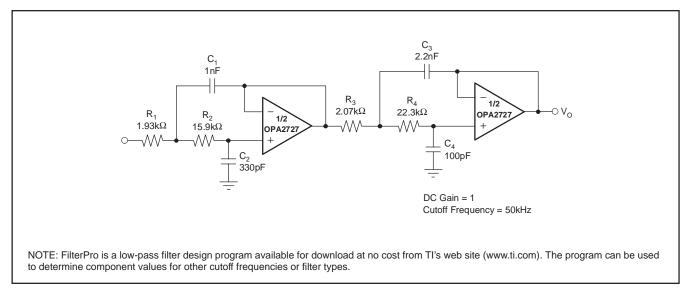


Figure 7. Four-Pole Butterworth Sallen-Key Low-Pass Filter

DFN PACKAGE

The OPA727 series uses the DFN-8 (also known as SON), which is a QFN package with lead contacts on only two sides of the bottom of the package. This leadless, near-chip-scale package maximizes board space and enhances thermal and electrical characteristics through an exposed pad.

DFN packages are physically small, have a smaller routing area, improved thermal performance, and improved electrical parasitics, with a pinout scheme that is consistent with other commonly-used packages, such as SO and MSOP. Additionally, the absence of external leads eliminates bent-lead issues.

The DFN package can be easily mounted using standard printed circuit board (PCB) assembly techniques. See Application Note, *QFN/SON PCB Attachment* (SLUA271) and Application Report, *Quad Flatpack No-Lead Logic Packages* (SCBA017), both available for download at www.ti.com.

The exposed leadframe die pad on the bottom of the package should be connected to V-.

LAYOUT GUIDELINES

The leadframe die pad should be soldered to a thermal pad on the PCB. A mechanical data sheet showing an example layout is attached at the end of this data sheet. Refinements to this layout may be required based on assembly process requirements. Mechanical drawings located at the end of this data sheet list the physical dimensions for the package and pad. The five holes in the landing pattern are optional, and are intended for use with thermal vias that connect the leadframe die pad to the heatsink area on the PCB.

Soldering the exposed pad significantly improves board-level reliability during temperature cycling, key push, package shear, and similar board-level tests. Even with applications that have low-power dissipation, the exposed pad must be soldered to the PCB to provide structural integrity and long-term reliability.





com 17-Oct-2006

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
OPA4727AIPWR	ACTIVE	TSSOP	PW	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA4727AIPWT	PREVIEW	TSSOP	PW	14		TBD	Call TI	Call TI
OPA727AIDGKR	ACTIVE	MSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA727AIDGKRG4	ACTIVE	MSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA727AIDGKT	ACTIVE	MSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA727AIDGKTG4	ACTIVE	MSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA727AIDRBR	ACTIVE	SON	DRB	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA727AIDRBRG4	ACTIVE	SON	DRB	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA727AIDRBT	ACTIVE	SON	DRB	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA727AIDRBTG4	ACTIVE	SON	DRB	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA728AIDGKR	ACTIVE	MSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA728AIDGKRG4	ACTIVE	MSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA728AIDGKT	ACTIVE	MSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA728AIDGKTG4	ACTIVE	MSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA728AIDRBR	ACTIVE	SON	DRB	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA728AIDRBRG4	ACTIVE	SON	DRB	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA728AIDRBT	ACTIVE	SON	DRB	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
OPA728AIDRBTG4	ACTIVE	SON	DRB	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



PACKAGE OPTION ADDENDUM

17-Oct-2006

compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



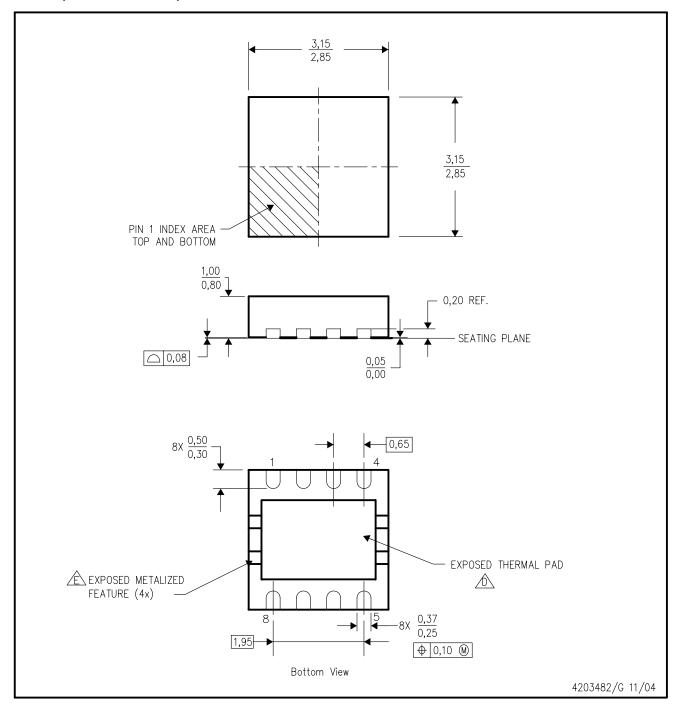
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.



DRB (S-PDSO-N8)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- C. Small Outline No-Lead (SON) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
- Metalized features are supplier options and may not be on the package.



PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DSP	dsp.ti.com	Broadband	www.ti.com/broadband
Interface	interface.ti.com	Digital Control	www.ti.com/digitalcontrol
Logic	logic.ti.com	Military	www.ti.com/military
Power Mgmt	power.ti.com	Optical Networking	www.ti.com/opticalnetwork
Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
Low Power Wireless	www.ti.com/lpw	Telephony	www.ti.com/telephony
		Video & Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless

Mailing Address: Texas Instruments

Post Office Box 655303 Dallas, Texas 75265

Copyright © 2006, Texas Instruments Incorporated